Docket No.

212425US9

TES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

GEORGE VALLIATH

SERIAL NO: 09 921,895

GAU:

2823

FILED:

AUGUST 6, 2001

EXAMINER: COLEMAN, W

FOR:

STRUCTURE AND METHOD FOR FABRICATION FOR A LIGHTING DEVICE

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

Applicant(s) wish to disclose the following information.

REFERENCES

- The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references were submitted in application Serial No. 09/908,888 according to the attached copy of a Granted Petition. This application contains related subject matter.
- A check is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- ☐ Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- A check is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- ☐ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check is enclosed herewith. or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

05/09/2003 SZEWDIE1 00000055 09921895

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Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NECSTADT, P.C.

Richard L. Treanor

Registration No. 36,379

Tei. (703) 413-3000 Fax. (703) 413-2220 (OSMMN 03-02)

Form PTO 1449	TRADE S DEPARTMENT OF COMMERCE			ATTY DOCKET NO.		SERIAL NO.	
Form PTO 1449 (Modified) PATENT AND TRADEMS DEPARTMENT OF COMMERCE PATENT AND TRADEMARY. OFFICE				212425US99		09/921,895	
				APPLICANT			
LIST OF	REFE	RENCES CITED BY AF	PPLICANT	George VALLIATH			
				FILING DATE		GROUP	
				August 6, 2001		2823	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	UT	5,528,209	06/18/96	Macdonald et al.			
	UV	5,998,781	12/07/99	Vawter et al.			
	UW	6,110,813	08/29/00	Ota et al.			
	UX	6,452,232 B1	09/17/02	Adan			
	UY	6,049,110	04/11/00	Koh			
	ŲΖ	5,559,368	09/24/96	Hu et al.			
	VA	6,392,253 B1	05/21/02	Saxena			
	VB	5,585,288	12/17/96	Davis et al.			
	VC	5,268,327	12/07/93	Vernon			
	VD	6,198,119 B1	03/06/01	Nabatame et al.			
	VE	6,113,225	09/05/00	Miyata et al.			
	VF	5,262,659	11/16/93	Grudkowski et al.			
	VG	6,239,012 B1	05/29/01	Kinsman			
	VH	6,297,598	10/02/01	Wang et al.			
	VI	2002/140012	10/03/02	Droopad			
	VJ	4,866,489	09/12/89	Yokogawa et al.			
	VK	6,080,378	06/27/00	Yokota et al.			
	VL	5,508,554	04/16/96	Takatani et al.			
	VM	6,477,285 B1	11/05/02	Shanley			
	VN	4,695,120	09/22/87	Holder			
-	VO	5,882,948	03/16/99	Jewell			
	VP	5,574,589	11/12/96	Feuer et al.			
	VQ	5,510,665	04/23/96	Conley			
	VR	4,804,866	02/14/89	Akiyama			
	VS	5,057,694	10/15/91	ldaka et al.			
	VT	5,635,453	06/03/97	Pique et al.			
	VU	5,719,417	02/17/98	Roeder et al.			
	VV	5,998,819	12/07/99	Yokoyama et al.			
Examiner					Date Co	nsidered	

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^{*}Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

TRADEMENT ATTY DOCKET NO. SERIAL NO. Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE 09/921,895 212425US99 **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT George VALLIATH GROUP FILING DATE August 6, 2001 2823 **U.S. PATENT DOCUMENTS** FILING DATE **EXAMINER** DOCUMENT SUB DATE CLASS NAME IF APPROPRIATE INITIAL NUMBER **CLASS** VW 2002/0079576 06/27/02 Seshan 5,148,504 09/15/92 Levi et al. VX 12/26/02 VY 2002/0195610 A1 Klosowiak ٧Z 5,477,363 12/19/95 Matsuda 05/18/99 Butler et al. WA 5,905,571 WB 5,570,226 10/29/96 Ota 02/11/92 WC 5,087,829 Ishibashi et al. WD 2001/0020278 A1 09/06/01 Saito WΕ 6,496,469 B1 12/17/02 Uchizaki WF 5,679,947 10/21/97 Doi et al. WG 11/01/01 Kadowaki et al. 2001/0036142 A1 08/29/95 Yoshida et al. WH 5,446,719 5,831,960 11/03/98 Jiang et al. 12/02/97 McKee et al. WJ 5,693,140 04/23/02 WK 6,376,337 B1 Wang et al. WL 4,177,094 12/04/79 Kroon 06/01/93 WM 5,216,359 Makki et al. WN 6,307,996 B1 10/23/01 Nashimoto et al. WO 12/06/94 Stevens 5,371,621 10/10/02 Bojarczuk, Jr et al. WP 2002/0145168 A1 11/02/71 Anderson WQ 3,617,951 WR 5,838,053 11/17/98 Bevan et al. 5,684,302 11/04/97 Wersing et al. WS WT 09/28/99 Shichijo et al. 5,959,308 11/08/94 WU 5,362,972 Yazawa et al. 01/26/99 Yamamoto et al. WV 5,864,171 WW 5,028,563 07/02/91 Feit et al. WX 5,937,115 08/10/99 Domash

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Examiner

Date Considered

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Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified)

LIST OF REFERENCES CITED BY APPLICANT

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George VALLIATH

FILING DATE

ATTY DOCKET NO. 12425US99

APPLICANT

George VALLIATH

FILING DATE

August 6, 2001

SERIAL NO. 09/921,895

APPLICANT

GROUP

2823

		FC	REIGN PATENT DOCUMENTS		
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO	
СВС	EP 1 035 759	09 13 00	Europe		
CBD		08 26 95	EUROPE		
CBE	5-232307	09 10 93	JAPAN W ENGLISH ABSTRACT		
CBF	5=243525	09-31.93	JAPAN W ENGLIGH ABSTRACT		
CBG	3-171617	07 25 91	JAPAN W ENGLISH ABSTRACT		
СВН	EP 1 089 338	04:04:01	EUROPE		
СВІ	01 294594	11 28 99	JAPAN (ABSTRACT)		
CBJ	05 221800	08/31/93	JAPAN (ABSTRACT)		
СВК	03-149882	11:07.89	JAPAN		
CBL	0 614 256	09/07/94	EUROPE		
СВМ	1 054 442	11 22.00	EUROPE		
CBN	0 852 416	07/08/98	EUROPE		
СВО	WO 02 08806	01 31 02	WIPO		
СВР	WO 01/59837	08/16:01	WIPO		
CBQ	62-245205	10 26 87	JAPAN W ENGLISH AESTRACT		
CBR	0 600 658	06, 08-94	EUROPE		
CBS	0 412 002	02 06 91	EUROPE		
СВТ	2000-349278	12, 15, 00	JAPAN (ENGLISH ABSTRACT)		
CBU	01=196809	08 08 89	JAPAN (ENGLISH ABSTRACT)		
CBV	0 619 283	10/12/94	EUROPE		
CBW	0 661 561	07 05 95	EUROPE		
CBX	0 331 338	09-06-89	EUROPE		
CBY					
CBZ					
CCA					
ССВ					
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	OTHER REFERENCES	(Including Author, Title, Date, Pertinent	Pages, etc.)					
KKA	Charles Kittel; "Introduction to Solid State Physics"; John Wiley & Sons, Inc. Fifth Edition; pp. 415							
KKA	Chyuan-Wei Chen et al: "Liquid-phase epitaxial growth and characterization of InGaAsP layers grown on GaAsP substrates for application to orange light emitting diodes": 931 Journal of Applied Physics: 77 (1995) 15 January, No. 2; Woodbury, XY, US: pp. 905-909							
KKA	W. Zhu et al.: "Oriented diamond films grown on nickel substrates"; 320 Applied Physics Letters; 63(1993) September, No. 12, Woodbury, NY, US; pp. 1640-1642							
KKA	M. Schreck et al.; "Diamond Ir SrTi03: A material combination for improved heteroepitaxial diamond films"; Applied Physics Letters; Vol. 74, No. 5; February 1, 1999; pp. 650-652							
KKA	Yoshihiro Yokota et al.; "Cathodoluminescence of boron-doped beteroepetaxial diamond films on platinum": Diamond and Related Materials 8(1999); pp. 1587-1591							
KKA	N.R. Busch et al.; "LINEAR ELECTRO-OPTIC RESPONSE IN SOL-GEL PZT PLANAR WAVEGUIDE"; Electronics Letters; 13th August 1992; Vol. 28, No. 17; pp. 1591-1592							
KKA	R. Droopad et al; "Epitaxial Oxide Films on Silicon: Growth, Modeling and Device Properties"; Mat. Res. Soc. Symp. Proc. Vol. 619; 2000 Materials Research Society; pp. 155-165							
KKA	H. Ohkubo et al.; "Fabrication of High Quality Perovskite Oxide Films by Lateral Epitaxy Verified with RHEED Oscillation"; 2419A Int. Conf. on Solid State Devices & Materials, Tsukuba, August 26-28 (1992); pp. 457-459							
KKA	Lin Li; "Ferroelectric Superconductor Heterostructures"; Materials Science and Engineering; 29 (2000) pp. / 153-181							
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KKA	Y. Q. Xu. et al.; "(Mn. Sb) dropped=Pb(Zr,Ti)03 infrared detector arrays"; Journal of Applied Physics; Vol. 88, No. 2; 15 July 2000; pp. 1004-1007							
KKA	Kiyoko Kato et al.: "Reduction of dislocations in InGaAs layer on GaAs using epitaxial lateral overgrowth"; 2300 Journal of Crystal Growth 115 (1991) pp. 174-179; Decomber 1991							
LLA	А							
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LLA	c							
LLA	D							
LLA	E							
Examiner			Date Considered					
	if reference is considered, whether or no not considered. Include copy of this form	ot citation is in conformance with MPEP 60s with next communication to applicant.	9; Draw line through citation if not in					